
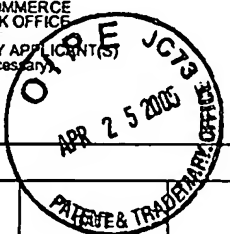

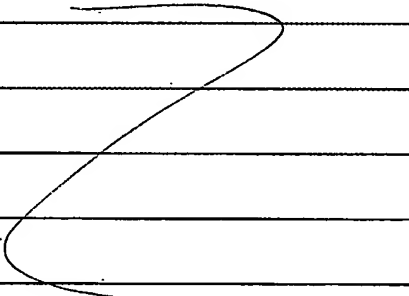
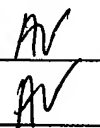
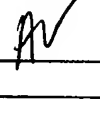
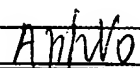



FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. <b>01272.020637</b>		APPLICATION NO. <b>10/671,619</b>	
				APPLICANT <b>Nobuyuki Kuwabara, et al</b>			
				FILING DATE <b>September 29, 2003</b>		GROUP <b>2867 Unknown</b>	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AV		5,854,646	12/29/98	Barinaga, et al	347	85	—
AV		6,540,321	4/1/03	Hirano, et al	347	22	—
AV		2003/128256	7/10/03	Atsumichi, et al			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
AV		803,364	10/29/97	Europe			
		1,149,706	7/31/02	Europe			
		1,190,860	3/27/02	Europe			
		1,231,062	8/14/02	Europe			
AV		2001-138541	5/22/01	Japan			Abstract
AV		2001-301194	20/3001	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			
AnhWo				05/05			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy, form with next communication to applicant.

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			APPLICANT <b>NOBUYUKI KUWABARA, et al.</b>			
			FILING DATE <b>September 29, 2003</b>		GROUP <b>N/Y/A</b>	
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	5,481,289	01/1996	Arashima, et al.	347	93	
	6,264,312	07/2001	Koitabashi, et al.	347	85	
	6,345,888	02/2002	Matsumoto, et al.	347	86	
	6,474,796	11/2002	Ishinaga	347	85	
	2003/0035036	02/2003	Ogura, et al.	347	86	
	2003/0067518	04/2003	Ishinaga, et al.	347	85	
	2003/0067520	04/2003	Inoue, et al.	347	86	
	2003/0128256	07/2003	Oda, et al.	347	85	
						
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
	JP 58-194560	11/1983	Japan			Abstract
	JP 2001-138541	05/2001	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER			DATE CONSIDERED			
						

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.